Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/791,815	FUJISAWA ET AL.	
Examiner	Art Unit	
David Buttner	1712	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE EXM		
west	12/5/2005 DB		
east	12/5/2005 DB		
chem ab	12/5/2005 DB		
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